

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	289	438/142.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/04/10 10:30
L3	399	438/421.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/04/10 10:30
S45	1	((solid adj state) semiconductor metal gate) near (layer film material)) AND (((no near more) less) near "40" near Angstroms) AND (atomic\$4 near smooth near surface) AND ((metallurgical\$3 metal\$3) near bond\$3) AND (sufficient\$2 uniform\$2 (defect near free\$2)).CLM.	US-PGPUB; USPAT	OR	ON	2005/11/04 08:24
S46	1	(method process\$3 fabricat\$3) AND (((solid adj state) semiconductor metal gate) near (layer film material)) AND (((no near more) less) near "40" near Angstroms) AND (atomic\$4 near smooth near surface) AND ((metallurgical\$3 metal\$3) near bond\$3) AND (sufficient\$2 uniform\$2 (defect near free\$2)).CLM.	US-PGPUB; USPAT	OR	ON	2005/11/04 08:26
S47	1	(method process\$3 fabricat\$3) AND (((solid adj state) semiconductor metal gate) near (layer film material)) AND pocket AND (((no near more) less) near "40" near Angstroms) AND (atomic\$4 near smooth near surface) AND ((metallurgical\$3 metal\$3) near bond\$3) AND (sufficient\$2 uniform\$2 (defect near free\$2)).CLM.	US-PGPUB; USPAT	OR	ON	2005/11/04 08:29
S48	0	(method process\$3 fabricat\$3) AND (((solid adj state) semiconductor metal gate) near (layer film material)) AND pocket AND (((no near more) less) near "40" near Angstroms) AND (atomic\$4 near smooth near surface) AND ((metallurgical\$3 metal\$3) near bond\$3) AND (sufficient\$2 uniform\$2 (defect near free\$2)) AND signal AND (interfac\$3 near rectify\$3 near barrier).CLM.	US-PGPUB; USPAT	OR	ON	2005/11/04 08:28

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S49	1	(method process\$3 fabricat\$3) AND (((solid adj state) semiconductor metal gate) near (layer film material)) AND pocket AND (((no near more) less) near ((".1" near micron) ("40" near Angstroms))) AND (atomic\$4 near smooth near surface) AND ((metallurgical\$3 metal\$3) near bond\$3) AND (sufficient\$2 uniform\$2 (defect near free\$2)).CLM.	US-PGPUB; USPAT	OR	ON	2005/11/04 08:36
S57	50	("5225366" "5281274" "5668402" "4339300" "4825335" "4920076" "4999735" "5275687" "5627383" "5811319" "5842387" "5872016" "5989947" "6020247" "6150242" "6277681" "6365059" "6420729" "6599132" "6613677" "6893500" "6921726" "6930835" "6963137" "5244619" "5456798" "5496292" "6140617" "4856235" "5722945" "5911699" "6203518" "4245023" "4252473" "4301040" "4329394" "4395914" "4452669" "4587152" "4772060" "4786342" "4792381" "4889598" "4915511" "4919922" "4945325" "4967463" "5223093" "5471303" "5492528").pn.	US-PGPUB; USPAT; USOCR	OR	ON	2006/04/04 10:36
S58	62	("2788298" "2795742" "2813048" "2815304" "2890395" "2899343" "2973290" "3015762" "3076104" "3081418" "3098160" "3100276" "3124452" "3132057" "3142021" "3150017" "3159780" "3192082" "3200311" "3200468" "3209428" "3216871" "3226225" "3226268" "3230609" "3233305" "3235779" "3237062" "3247428" "3252062" "3255055").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/04/04 10:36